

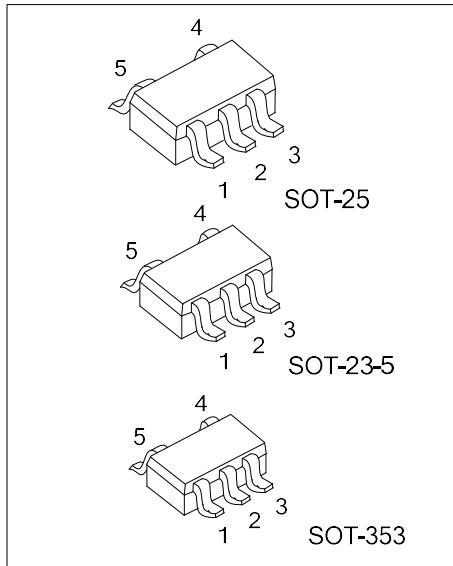
**U74LVC1G00****CMOS IC****SINGLE 2-INPUT NAND GATE****■ DESCRIPTION**

The **U74LVC1G00** is a 2-input NAND gate device which provides the Function  $Y=A \cdot B$  or  $Y=\overline{A} + \overline{B}$  in positive logic.

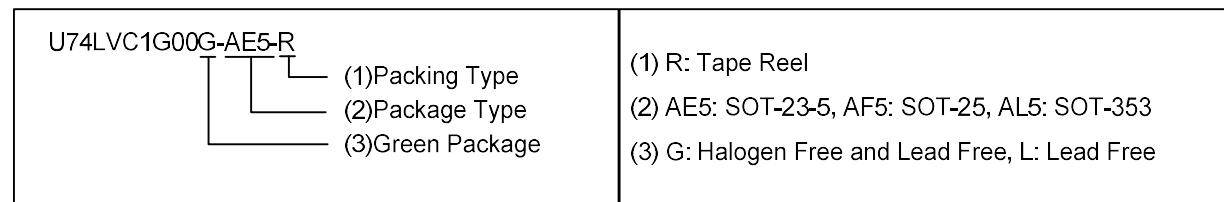
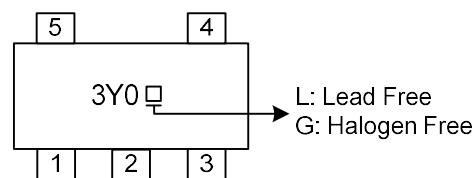
This device has power-down protective circuit preventing device from destruction when it is powered down.

**■ FEATURES**

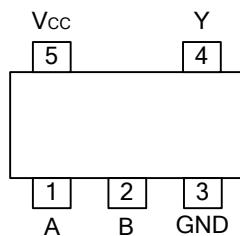
- \* Operate From 1.65V to 5.5V
- \* Inputs Accept Voltages To 5.5V
- \* High Noise Immunity
- \* Low Power Dissipation

**■ ORDERING INFORMATION**

Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74LVC1G00L-AE5-R	U74LVC1G00G-AE5-R	SOT-23-5	Tape Reel
U74LVC1G00L-AF5-R	U74LVC1G00G-AF5-R	SOT-25	Tape Reel
U74LVC1G00L-AL5-R	U74LVC1G00G-AL5-R	SOT-353	Tape Reel

**■ MARKING**

## ■ PIN CONFIGURATION

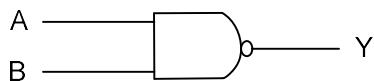


## ■ FUNCTION TABLE

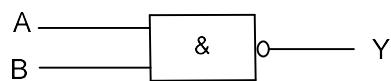
INPUT(A)	INPUT(B)	OUTPUT(Y)
H	H	L
H	L	H
L	H	H
L	L	H

Note: H: HIGH voltage level; L: LOW voltage level.

## ■ LOGIC DIAGRAM (positive logic)



Logic symbol



IEC logic symbol

■ **ABSOLUTE MAXIMUM RATING** ( $T_A=25^\circ\text{C}$  , unless otherwise specified)

PARAMETER	SYMBOL	CONDITIONS	RATINGS	UNIT
Supply Voltage	$V_{CC}$		-0.5 ~ +6.5	V
Input Voltage	$V_{IN}$		-0.5 ~ +6.5	V
Output Voltage	$V_{OUT}$	Output in the Power-off state	-0.5 ~ +6.5	V
		Output in the High or Low state	-0.5 ~ $V_{CC}+0.5$	V
$V_{CC}$ or GND Current	$I_{CC}$	Output in the Power-off state	$\pm 100$	mA
Continuous Output Current	$I_{OUT}$	$V_{OUT}=0\sim V_{CC}$	$\pm 50$	mA
Input Clamp Current	$I_{IK}$	$V_{IN}<0$	-50	mA
Output Clamp Current	$I_{OK}$	$V_{OUT}<0$	-50	mA
Storage Temperature Range	$T_{STG}$		-65 ~ +150	$^\circ\text{C}$

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ **THERMAL DATA**

PARAMETER	SYMBOL	RATINGS		UNIT
Junction to Ambient	SOT-23-5	$\theta_{JA}$	280	$^\circ\text{C}/\text{W}$
	SOT-25		230	
	SOT-353		350	

■ **RECOMMENDED OPERATING CONDITIONS**

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	$V_{CC}$	Operating	1.65		5.5	V
		Data retention only	1.5			V
Input Voltage	$V_{IN}$		0		5.5	V
Output Voltage	$V_{OUT}$	High or Low state	0		$V_{CC}$	V
High-level Output Current	$I_{OH}$	$V_{CC}=1.65\text{V}$			-4	mA
		$V_{CC}=2.3\text{V}$			-8	mA
		$V_{CC}=3\text{V}$			-16	mA
		$V_{CC}=3\text{V}$			-24	mA
		$V_{CC}=4.5\text{V}$			-32	mA
Low-level Output Current	$I_{OL}$	$V_{CC}=1.65\text{V}$			4	mA
		$V_{CC}=2.3\text{V}$			8	mA
		$V_{CC}=3\text{V}$			16	mA
		$V_{CC}=3\text{V}$			24	mA
		$V_{CC}=4.5\text{V}$			32	mA
Input Transition Rise or Fall Rate	$t_R / t_F$	$V_{CC}=1.8\text{V}\pm 0.15\text{V}, 2.5\text{V}\pm 0.2\text{V}$			20	ns/V
		$V_{CC}=3.3\text{V}\pm 0.3\text{V}$			10	ns/V
		$V_{CC}=5\text{V}\pm 0.5\text{V}$			5	ns/V
Operating Temperature	$T_A$		-40		+125	$^\circ\text{C}$

■ ELECTRICAL CHARACTERISTICS (Unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	T <sub>A</sub> =25°C			T <sub>A</sub> =-40~+125°C			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
High-Level Input Voltage	V <sub>IH</sub>	V <sub>CC</sub> =1.65V~1.95V	0.65 ×V <sub>CC</sub>			0.65 ×V <sub>CC</sub>			V
		V <sub>CC</sub> =2.3V~2.7V	1.7			1.7			V
		V <sub>CC</sub> =3V~3.6V	2			2			V
		V <sub>CC</sub> =4.5V~5.5V	0.7 ×V <sub>CC</sub>			0.7 ×V <sub>CC</sub>			V
Low-Level Input Voltage	V <sub>IL</sub>	V <sub>CC</sub> =1.65V~1.95V			0.35 ×V <sub>CC</sub>			0.35 ×V <sub>CC</sub>	V
		V <sub>CC</sub> =2.3V~2.7V			0.7			0.7	V
		V <sub>CC</sub> =3V~3.6V			0.8			0.8	V
		V <sub>CC</sub> =4.5V~5.5V			0.3 ×V <sub>CC</sub>			0.3 ×V <sub>CC</sub>	V
High-Level Output Voltage	V <sub>OH</sub>	V <sub>CC</sub> =1.65~5.5V, I <sub>OH</sub> =-100μA	V <sub>CC</sub> -0.1			V <sub>CC</sub> -0.1			V
		V <sub>CC</sub> =1.65V, I <sub>OH</sub> =-4mA	1.2			0.95			V
		V <sub>CC</sub> =2.3V, I <sub>OH</sub> =-8mA	1.9			1.7			V
		V <sub>CC</sub> =3.0V, I <sub>OH</sub> =-16mA	2.4			1.9			V
		V <sub>CC</sub> =3.0V, I <sub>OH</sub> =-24mA	2.3			2.0			V
		V <sub>CC</sub> =4.5V, I <sub>OH</sub> =-32mA	3.8			3.4			V
Low-Level Output Voltage	V <sub>OL</sub>	V <sub>CC</sub> =1.65~5.5V, I <sub>OL</sub> =100μA			0.1			0.1	V
		V <sub>CC</sub> =1.65V, I <sub>OL</sub> =4mA			0.45			0.7	V
		V <sub>CC</sub> =2.3V, I <sub>OL</sub> =8mA			0.3			0.45	V
		V <sub>CC</sub> =3.0V, I <sub>OL</sub> =16mA			0.4			0.6	V
		V <sub>CC</sub> =3.0V, I <sub>OL</sub> =24mA			0.55			0.80	V
		V <sub>CC</sub> =4.5V, I <sub>OL</sub> =32mA			0.55			0.80	V
Input Leakage Current	I <sub>I(LEAK)</sub>	V <sub>IN</sub> =5.5V or GND, V <sub>CC</sub> =0 ~ 5.5V			±5			±5	μA
Power OFF Leakage Current	I <sub>OFF</sub>	V <sub>IN</sub> or V <sub>OUT</sub> =5.5V, V <sub>CC</sub> =0V			±10			±10	μA
Quiescent Supply Current	I <sub>Q</sub>	V <sub>IN</sub> =V <sub>CC</sub> or GND, I <sub>OUT</sub> =0, V <sub>CC</sub> =1.65~5.5V			10			10	μA
Additional Quiescent Supply Current Per Input Pin	ΔI <sub>Q</sub>	V <sub>CC</sub> =3~5.5V, One input at V <sub>CC</sub> -0.6V, Other inputs at V <sub>CC</sub> or GND			500			500	μA

■ SWITCHING CHARACTERISTICS (Unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	T <sub>A</sub> =25°C			T <sub>A</sub> =-40~+125°C			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
Propagation delay from input (A or B) to output(Y)	t <sub>PLH</sub> / t <sub>PHL</sub>	V <sub>CC</sub> =1.8±0.15V	1.0		8.2	1.0		9.7	ns
		V <sub>CC</sub> =2.5±0.2V	0.5		5.4	0.5		6.9	ns
		V <sub>CC</sub> =3.3±0.3V	0.5		4.8	0.5		6.3	ns
		V <sub>CC</sub> =5±0.5V	0.5		4.4	0.5		5.9	ns
		V <sub>CC</sub> =1.8±0.15V, R <sub>L</sub> =1KΩ	1.0		11	1.0		12	ns
		V <sub>CC</sub> =2.5±0.2V, R <sub>L</sub> =500Ω	0.5		7	0.5		9	ns
		V <sub>CC</sub> =3.3±0.3V, R <sub>L</sub> =500Ω	0.5		6.2	0.5		8.2	ns
		V <sub>CC</sub> =5±0.5V, R <sub>L</sub> =500Ω	0.5		5.1	0.5		6.5	ns
		C <sub>L</sub> =15pF R <sub>L</sub> =1MΩ			C <sub>L</sub> =30pF	1.0	11	1.0	ns

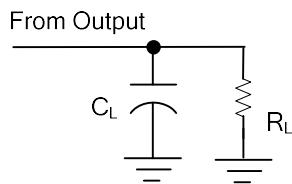
# U74LVC1G00

CMOS IC

## ■ OPERATING CHARACTERISTICS (f=10MHz, TA=25°C, unless otherwise specified)

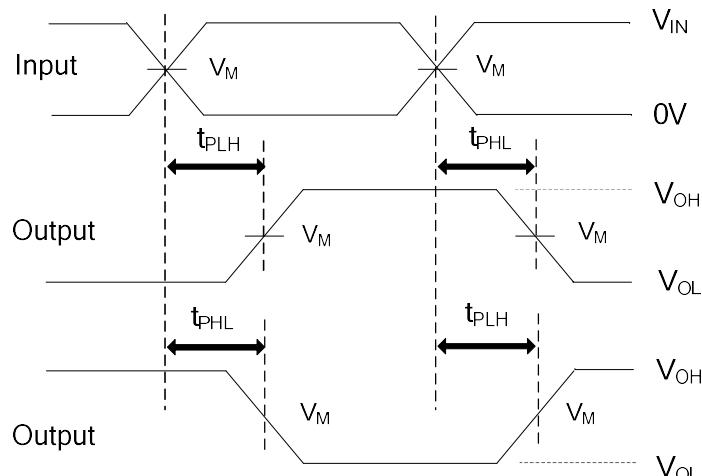
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input Capacitance	C <sub>I</sub>	V <sub>CC</sub> =3.3V, V <sub>IN</sub> =V <sub>CC</sub> or GND	4			pF
Power Dissipation Capacitance	C <sub>PD</sub>	V <sub>CC</sub> =1.8V		22		pF
		V <sub>CC</sub> =2.5V		22		pF
		V <sub>CC</sub> =3.3V		23		pF
		V <sub>CC</sub> =5.0V		25		pF

## ■ TEST CIRCUIT AND WAVEFORMS



TEST CIRCUIT

$V_{CC}$	Inputs		$V_M$	$C_L$	$R_L$
	$V_{IN}$	$t_R, t_F$			
1.8V±0.15V	$V_{CC}$	$\leq 2\text{ns}$	$V_{CC}/2$	15pF	1MΩ
2.5V±0.2V	$V_{CC}$	$\leq 2\text{ns}$	$V_{CC}/2$	15pF	1MΩ
3.3V±0.3V	3V	$\leq 2.5\text{ns}$	1.5V	15pF	1MΩ
5V±0.5V	$V_{CC}$	$\leq 2.5\text{ns}$	$V_{CC}/2$	15pF	1MΩ

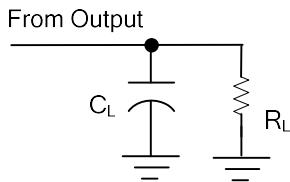


PROPAGATION DELAY TIMES

Note:  $C_L$  includes probe and jig capacitance.

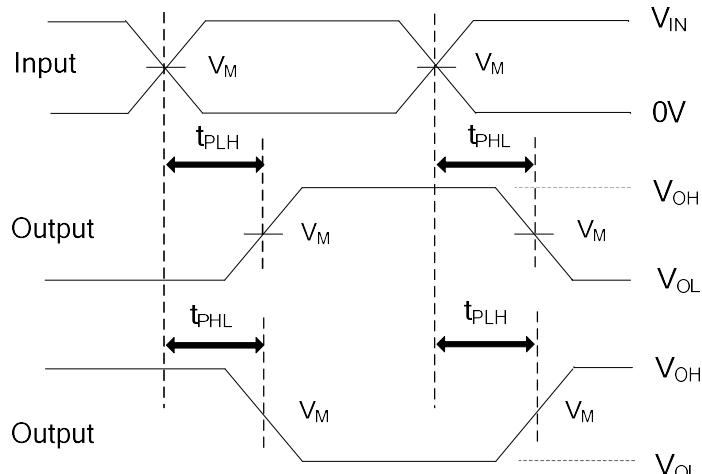
All input pulses are supplied by generators having the following characteristics:  $P_{RR} \leq 10\text{MHz}$ ,  $Z_0 = 50\Omega$ .

## ■ TEST CIRCUIT AND WAVEFORMS (Cont.)



TEST CIRCUIT

$V_{CC}$	Inputs		$V_M$	$C_L$	$R_L$
	$V_{IN}$	$t_R, t_F$			
1.8V±0.15V	$V_{CC}$	$\leq 2\text{ns}$	$V_{CC}/2$	30pF	1KΩ
2.5V±0.2V	$V_{CC}$	$\leq 2\text{ns}$	$V_{CC}/2$	30pF	500Ω
3.3V±0.3V	3V	$\leq 2.5\text{ns}$	1.5V	50pF	500Ω
5V±0.5V	$V_{CC}$	$\leq 2.5\text{ns}$	$V_{CC}/2$	50pF	500Ω



PROPAGATION DELAY TIMES

Note:  $C_L$  includes probe and jig capacitance.

All input pulses are supplied by generators having the following characteristics:  $P_{RR} \leq 10\text{MHz}$ ,  $Z_0 = 50\Omega$ .

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.